## Search Notes



Application/Control I	10
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Applicant(s)/Patent Under Reexamination

YEOW ET AL.

Examiner

VANEL FRENEL

Art Unit

3687

## **SEARCHED**

Class	Subclass	Date	Examiner
705	28	4/12/08	V.F
705	10	4/12/08	V.F

## **SEARCH NOTES**

Search Notes	Date	Examiner

## **INTERFERENCE SEARCH**

Class	Subclass	Date	Examiner

U.S. Patent and Trademark Office Part of Paper No.: 20080412